

July 2014

FDMA1029PZ

Dual P-Channel PowerTrench® MOSFET

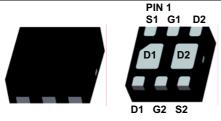
General Description

This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. When connected in the typical common source configuration, bi-directional current flow is possible.

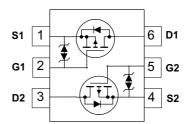
The MicroFET 2x2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications.

Features

- -3.1 A, -20V. $R_{DS(ON)} = 95 \text{ m}\Omega$ @ $V_{GS} = -4.5V$ $R_{DS(ON)} = 141 \text{ m}\Omega$ @ $V_{GS} = -2.5V$
- Low profile 0.8 mm maximum in the new package MicroFET 2x2 mm
- HBM ESD protection level > 2.5kV (Note 3)
- RoHS Compliant
- Free from halogenated compounds and antimony oxides



MicroFET 2x2



Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DS}	Drain-Source Voltage		-20	V
V _{GS}	Gate-Source Voltage		±12	V
ı	Drain Current - Continuous	(Note 1a)	-3.1	A
I _D	– Pulsed		-6	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.4	W
		(Note 1b)	0.7	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	86 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	173 (Single Operation)	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1c)	69 (Dual Operation)	- C/VV
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	151 (Dual Operation)	

Package Marking and Ordering Information

Device Marking Device		Reel Size	Tape width	Quantity	
029	FDMA1029PZ	7"	8mm	3000 units	

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	,				
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-20			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		-12		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μА
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	-0.6	-1.0	-1.5	V
ΔV _{GS(th)} ΔT _J	Gate Threshold Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C		4		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -3.1 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -2.5 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -3.1 \text{ A}, T_J = 125 ^{\circ}\text{C}$		60 88 87	95 141 140	mΩ
g FS	Forward Transconductance	$V_{DS} = -10 \text{ V}, I_{D} = -3.1 \text{ A}$		-11		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		540		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		120		pF
C _{rss}	Reverse Transfer Capacitance			100		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$		13	24	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		11	20	ns
t _{d(off)}	Turn-Off Delay Time]		37	59	ns
t _f	Turn-Off Fall Time	1		36	58	ns
Q_g	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -3.1 \text{ A},$		7.0	10	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		1.1		nC
Q_{gd}	Gate-Drain Charge]		2.4		nC

 $V_{GS} = 0 \text{ V}, I_S = -1.1 \text{ A}$ (Note 2)

 $I_F = -3.1 A$

 $dI_F/dt = 100 A/\mu s$

V_{SD}

t_{rr}

 Q_{rr}

Source-Drain Diode Forward

Diode Reverse Recovery Time

Diode Reverse Recovery Charge

Voltage

-0.8

25

9

-1.2

ns

nC

Notes:

- 1. R_{BJA} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{BJC} is guaranteed by design while R_{BJA} is determined by the user's board design.

 (a) R_{BJA} = 86 °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.

 (b) R_{BJA} = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.

 - (c) $R_{\theta JA}$ = 69 °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.
 - (d) $R_{\theta JA}$ = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.



- $3. \ The \ diode \ connected \ between \ the \ gate \ and \ source \ serves \ only \ as \ protection \ against \ ESD. \ No \ gate \ overvoltage \ rating \ is \ implied.$

Typical Characteristics

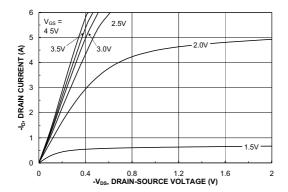


Figure 1. On-Region Characteristics.

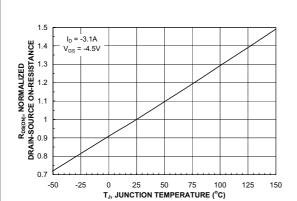


Figure 3. On-Resistance Variation with Temperature.

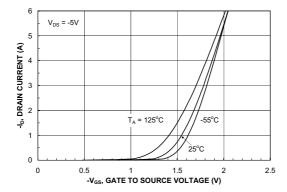


Figure 5. Transfer Characteristics.

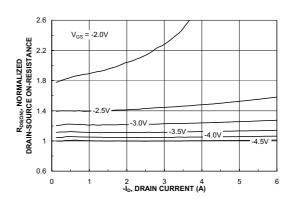


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

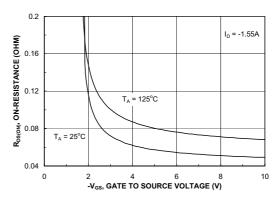


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

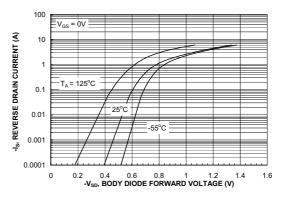
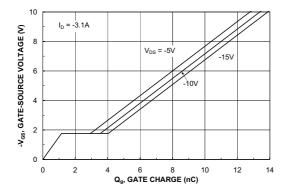


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



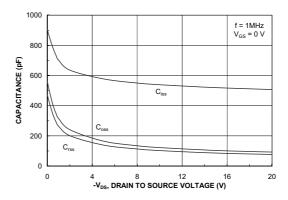
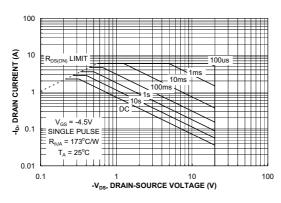


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



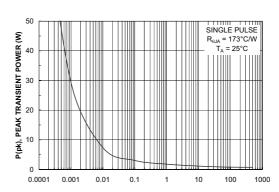


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

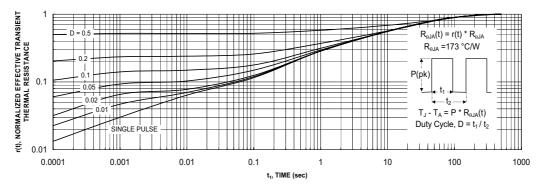
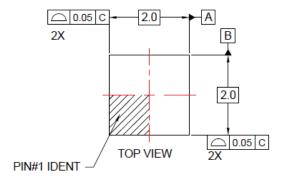
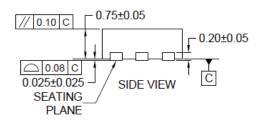


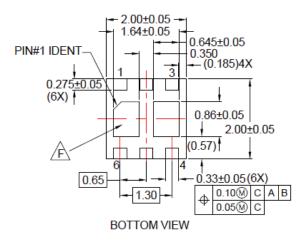
Figure 11. Transient Thermal Response Curve.

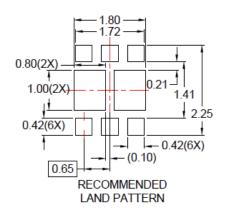
Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout









NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-UMLP16Erev4
- F. NON-JEDEC DUAL DAP



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